AUTOMOTIVE GRADE

AUIRF3205Z AUIRF3205ZS

HEXEET[®] Power MOSEET

Features

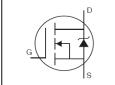
- Advanced Process Technology
- Ultra Low On-Resistance

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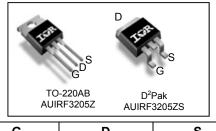
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Tjmax
- Lead-Free, RoHS Compliant
- Automotive Qualified *

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.



V _{DSS}	55V
R _{DS(on)} max.	6.5mΩ
ID (Silicon Limited)	110A
I _{D (Package Limited)}	75A



9	U	3
Gate	Drain	Source

Base next number Baskage Ture		Standard Pack		Orderable Part Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number	
AUIRF3205Z	TO-220	Tube	50	AUIRF3205Z	
	D ² -Pak	Tube	50	AUIRF3205ZS	
AUIRF3205ZS	D -Pak	Tape and Reel Left	800	AUIRF3205ZSTRL	

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	110	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	78	•
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	75	A
I _{DM}	Pulsed Drain Current ①	440	
P _D @T _C = 25°C	Maximum Power Dissipation	170	W
	Linear Derating Factor	1.1	W/°C
V _{GS}	Gate-to-Source Voltage	± 20	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) 2	180	- m l
E _{AS} (tested)	Single Pulse Avalanche Energy Tested Value 6	250	mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	А
E _{AR}	Repetitive Avalanche Energy S		mJ
TJ	Operating Junction and	-55 to + 175	
T _{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	
	Mounting torque, 6-32 or M3 screw®	10 lbf•in (1.1N•m)	

Thermal Resistance Symbol Parameter Units Max. Тур. $\mathsf{R}_{\theta \mathsf{JC}}$ Junction-to-Case® 0.90 Case-to-Sink, Flat, Greased Surface ⑦ 0.50 R_{0CS} ____ °C/W Junction-to-Ambient 🗇 62 $\mathsf{R}_{\theta \mathsf{JA}}$ Junction-to-Ambient (PCB Mount, steady state) (8) 40 R_{0JA}

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*Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter		Тур.	Max.	Units	Conditions
V _{(BR)DSS}	Drain-to-Source Breakdown Voltage	55			V	V _{GS} = 0V, I _D = 250µA
$\Delta V_{(BR)DSS} / \Delta T_J$	Breakdown Voltage Temp. Coefficient		0.051		V/°C	Reference to 25° C, I _D = 1mA
R _{DS(on)}	Static Drain-to-Source On-Resistance		4.9	6.5	mΩ	V _{GS} = 10V, I _D = 66A
V _{GS(th)}	Gate Threshold Voltage	2.0		4.0	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$
gfs	Forward Trans conductance	71			S	V _{DS} = 25V, I _D = 66A
	Drain-to-Source Leakage Current			20	μA	V _{DS} = 55V, V _{GS} = 0V
IDSS	Drain-to-Source Leakage Current			250	μΑ	V _{DS} = 55V,V _{GS} = 0V,T _J =125°C
I _{GSS}	Gate-to-Source Forward Leakage			200	n A	V _{GS} = 20V
	Gate-to-Source Reverse Leakage			-200	nA	V _{GS} = -20V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q _g	Total Gate Charge		76	110		I _D = 66A
Q_{gs}	Gate-to-Source Charge		21		nC	$V_{DS} = 44V$
Q_{gd}	Gate-to-Drain Charge		30			V _{GS} = 10V③
t _{d(on)}	Turn-On Delay Time		18			$V_{DD} = 28V$
t _r	Rise Time		95		ns	I _D = 66A
t _{d(off)}	Turn-Off Delay Time		45		115	R _G = 6.8Ω,
t _f	Fall Time		67			V _{GS} = 10V ③
L _D	Internal Drain Inductance		4.5		nH	Between lead, 6mm (0.25in.)
L _S	Internal Source Inductance		7.5		1111	from package and center of die contact:
C _{iss}	Input Capacitance		3450			V _{GS} = 0V
C _{oss}	Output Capacitance		550			V _{DS} = 25V
C _{rss}	Reverse Transfer Capacitance		310		~ F	f = 1.0MHz
C _{oss}	Output Capacitance		1940		pF	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
C _{oss}	Output Capacitance		430			$V_{GS} = 0V, V_{DS} = 44V f = 1.0MHz$
Coss eff.	Effective Output Capacitance		640			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 44V \oplus$
Diode Chara	cteristics					
	Parameter	Min.	Тур.	Max.	Units	Conditions
ls	Continuous Source Current (Body Diode)			75	_	MOSFET symbol showing the
I _{SM}	Pulsed Source Current (Body Diode) ①			440	A	integral reverse
		1	1	1	1	

Notes:

 V_{SD}

t_{rr}

Qrr

t_{on}

① Repetitive rating; pulse width limited by max. junction temperature. (See fig.11)

Limited by T_{Jmax}, starting T_J = 25°C, L = 0.08mH, R_G = 25Ω, I_{AS} = 66A, V_{GS} = 10V. Part not recommended for use above this value.
Pulse width ≤ 1.0ms; duty cycle ≤ 2%.

1.3

42

38

28

25

V

ns

nC

④ C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.

S Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.

(i) This value determined from sample failure population, starting $T_J = 25^{\circ}C$, L = 0.08mH, $R_G = 25\Omega$, $I_{AS} = 66A$, $V_{GS} = 10V$.

⑦ This is only applied to TO-220AB package.

Diode Forward Voltage

Reverse Recovery Time

Forward Turn-On Time

Reverse Recovery Charge

It is applied to D² Pak, When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994

 $\begin{tabular}{ll} \end{tabular} \end{tabular} \end{tabular} \end{tabular} \end{tabular} R_\theta \end{tabular} \en$

 $T_J = 25^{\circ}C, I_S = 66A, V_{GS} = 0V$ 3

T_J = 25°C ,I_F = 66A , V_{DD} = 25V

di/dt = 100A/µs ③

Intrinsic turn-on time is negligible (turn-on is dominated by L_S+L_D)



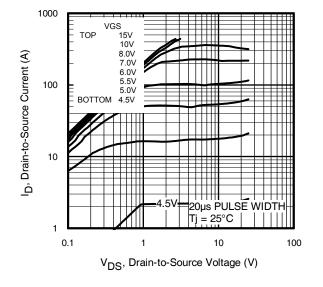


Fig. 1 Typical Output Characteristics

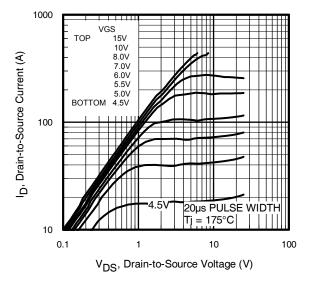


Fig. 2 Typical Output Characteristics

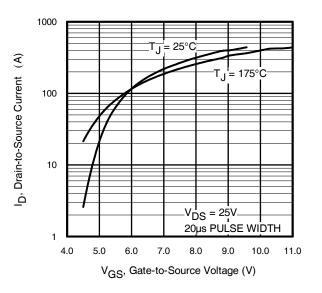


Fig. 3 Typical Transfer Characteristics

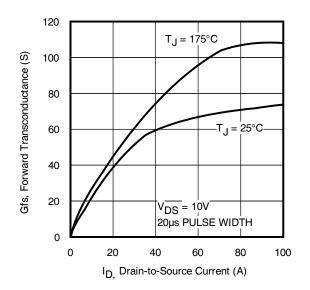


Fig. 4 Typical Forward Trans conductance vs. Drain Current



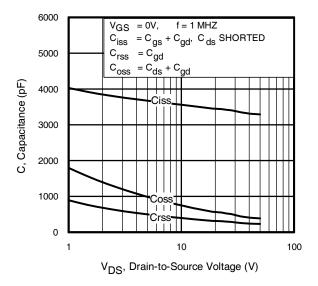


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

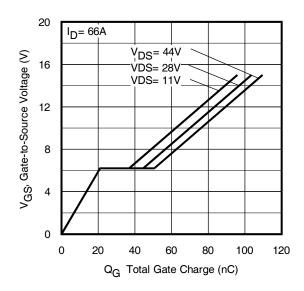


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

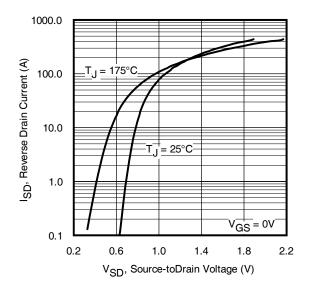


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

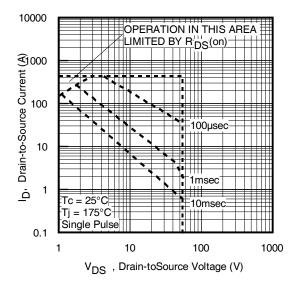


Fig 8. Maximum Safe Operating Area



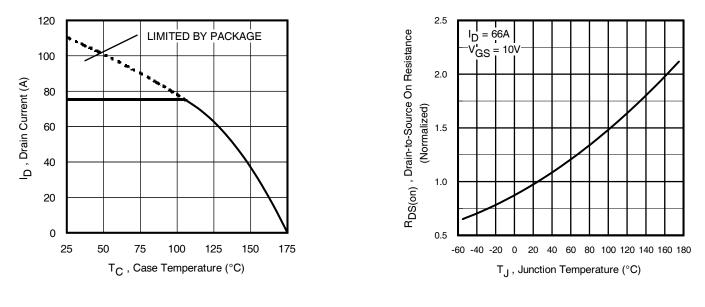
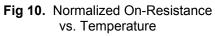


Fig 9. Maximum Drain Current vs. Case Temperature



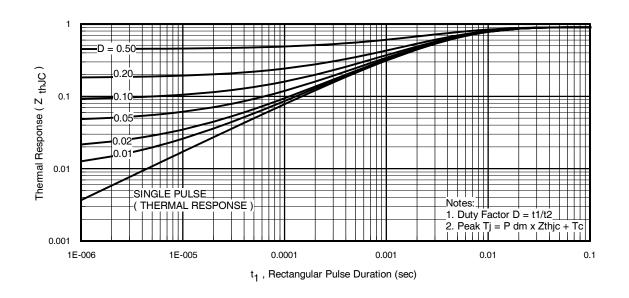


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

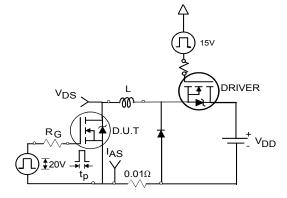


Fig 12a. Unclamped Inductive Test Circuit

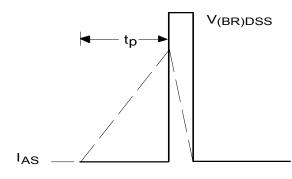


Fig 12b. Unclamped Inductive Waveforms

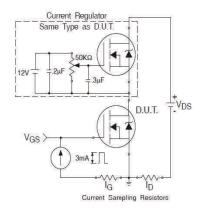


Fig 13a. Gate Charge Test Circuit

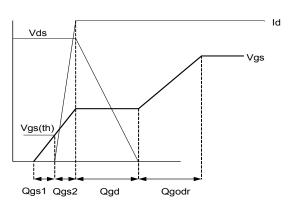


Fig 13b. Gate Charge Waveform

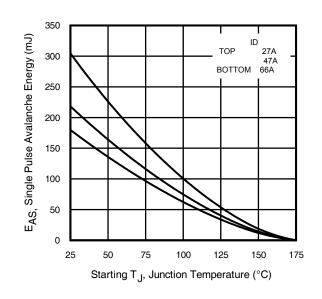


Fig 12c. Maximum Avalanche Energy vs. Drain Current

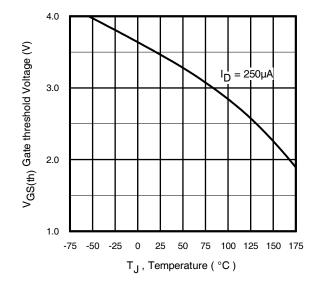


Fig 14. Threshold Voltage vs. Temperature



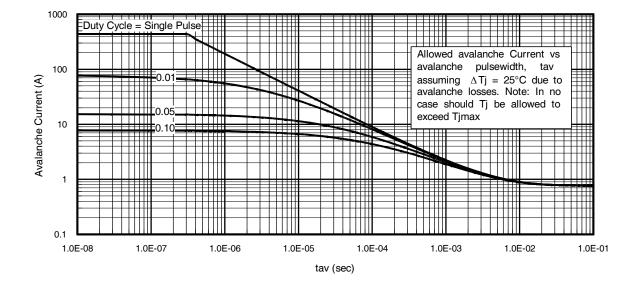


Fig 15. Avalanche Current vs. Pulse width

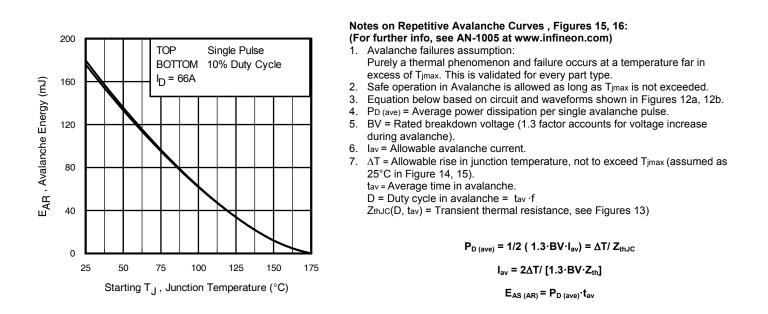


Fig 16. Maximum Avalanche Energy vs. Temperature

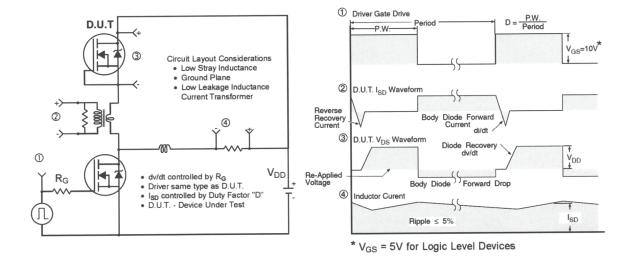


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

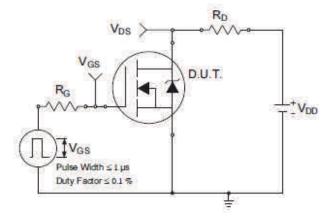


Fig 18a. Switching Time Test Circuit

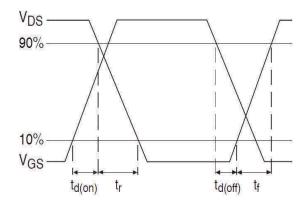
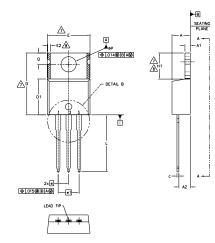


Fig 18b. Switching Time Waveforms



TO-220AB Package Outline (Dimensions are shown in millimeters (inches))





- DIMENSIONING AND TOLERANCING AS PER ASME Y14.5 M- 1994. 1.-
- DIMENSIONS ARE SHOWN IN INCHES [MILLIMETERS]. 2.-
- LEAD DIMENSION AND FINISH UNCONTROLLED IN LI 3.-
- DIMENSION D, D1 & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE 4.-MEASURED AT THE OUTERWOST EXTREMES OF THE PLASTIC BODY.
- DIMENSION 61, 63 & c1 APPLY TO BASE METAL ONLY.
- <u>/5.</u>_ 6.-CONTROLLING DIMENSION : INCHES.
- THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS E,H1,D2 & E1 7.-
- DIMENSION E2 X H1 DEFINE A ZONE WHERE STAMPING AND SINGULATION IRREGULARITIES ARE ALLOWED. 8.–
- UTUINE CONFORMS TO JEDEC TO -220, EXCEPT A2 (max.) AND D2 (min.) WHERE DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE OUTLINE. 9.-

	DIMENSIONS				
SYMBOL	MILLIM	ETERS	INC	HES	
	Min.	MAX.	MIN.	MAX.	NOTES
A	3.56	4.83	.140	.190	
A1	1,14	1.40	.045	.055	
A2	2.03	2.92	.080	.115	
b	0.38	1.01	.015	.040	
b1	0.38	0.97	.015	.038	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
с	0.36	0.61	.014	.024	
c1	0.36	0.56	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.38	9.02	.330	.355	
D2	11.68	12.88	.460	.507	7
E	9.65	10.67	.380	.420	4,7
E1	6.86	8.89	.270	.350	7
E2	-	0.76	-	.030	8
е	2.54 5.08	BSC	.100	BSC BSC	
e1	5.08	BSC	.200	BSC	
H1	5.84	6.86	.230	.270	7,8
L	12.70	14.73	.500	.580	
L1	3.56	4.06	.140	.160	3
øР	3.54	4.08	.139	.161	
Q	2.54	3.42	.100	.135	

LEAD ASSIGNMENTS

<u>HEXFET</u> 1.- GATE 2.- DRAIN

J	JUUNCL	
ICRTe	CoPACK	
IGD IS.	COFACK	

1.- GATE 2.- COLLECTOR 3.- EMITTER

DIODES

1.- ANODE 2.- CATHODE 3.- ANODE

TO-220AB Part Marking Information

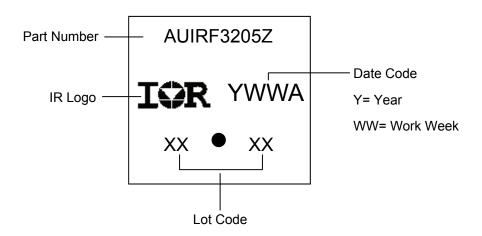
e1 A

VEW A-A

DETAIL B

-61,63-6

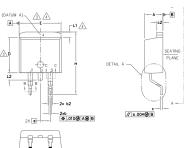
SECTION C-C & D-D



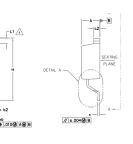
Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



D²Pak (TO-263AB) Package Outline (Dimensions are shown in millimeters (inches))



AD TIF





- 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2. DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].

DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED 0.127 [.005"] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY AT DATUM H.

4. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSION E, L1, D1 & E1.

5. DIMENSION 61, 63 AND c1 APPLY TO BASE METAL ONLY.

6. DATUM A & B TO BE DETERMINED AT DATUM PLANE H.

7. CONTROLLING DIMENSION: INCH.

8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-263AB.

PLATING BASE META
DETAIL "A" ROTATED 90' CW SCALE 8:1

S Y M	DIMENSIONS				
В	MILLIM	eters	INC	HES	O T E S
0 L	MIN.	MAX.	MIN.	MAX.	L S
А	4.06	4.83	.160	.190	
A1	0.00	0.254	.000	.010	
Ь	0.51	0.99	.020	.039	
Ь1	0.51	0.89	.020	.035	5
b2	1.14	1.78	.045	.070	
b3	1.14	1.73	.045	.068	5
С	0.38	0.74	.015	.029	
с1	0.38	0.58	.015	.023	5
c2	1.14	1.65	.045	.065	
D	8.38	9.65	.330	.380	3
D1	6.86	_	.270	_	4
Е	9.65	10.67	.380	.420	3,4
E1	6.22	-	.245	—	4
е	2.54	BSC	.100	BSC	
Н	14.61	15.88	.575	.625	
L	1.78	2.79	.070	.110	
∟1	_	1.68	-	.066	4
L2	_	1.78	-	.070	
L3	0.25	BSC	.010	BSC	

LEAD ASSIGNMENTS

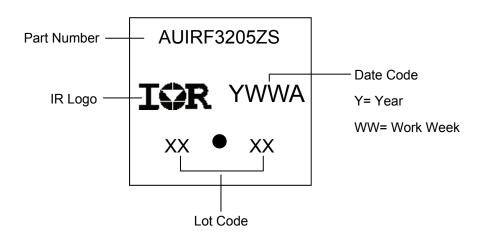
DIODES 1.- ANODE (TWO DIE) / OPEN (ONE DIE) 2, 4.- CATHODE 3.- ANODE

> IGBTS, COPACK 1.- GATE 2, 4.- COLLECTOR 3.- EMITTER



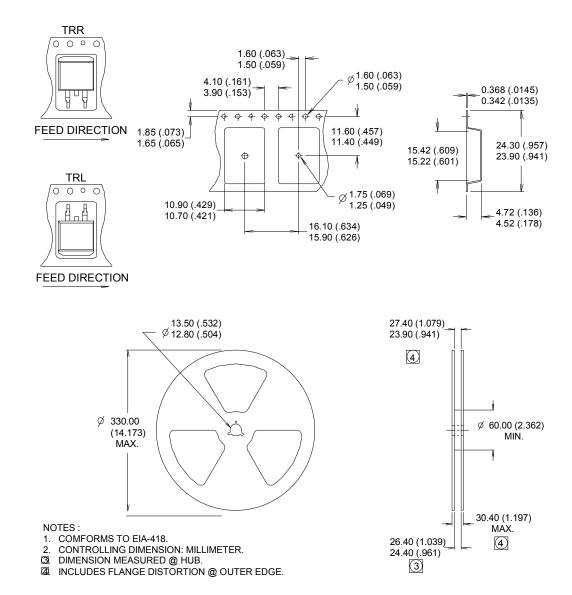
HEXFET

D²Pak (TO-263AB) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

D²Pak (TO-263AB) Tape & Reel Information (Dimensions are shown in millimeters (inches))



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive (per AEC-Q101)				
Qualificati	ion Level	Comments: This part number(s) passed Automotive qualification. Infined Industrial and Consumer qualification level is granted by extension of the hig Automotive level.				
	o	TO-220 Pak N/A				
Moisture Sensitivity Level		D ² -Pak	MSL1			
	Machine Model	Class M4 (+/- 425V) [†] AEC-Q101-002				
ESD	Human Body Model	Class H1C (+/- 2000V) [†] AEC-Q101-001				
	Charged Device Model	Class C5 (+/- 1125V) [†] AEC-Q101-005				
RoHS Cor	npliant	Yes				

† Highest passing voltage.

Revision History

Date	Comments		
11/13/2015	Updated datasheet with corporate template		
	Corrected ordering table on page 1.		

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